

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/557,694 HADA ET AL.	
		Examiner	Art Unit ANCA EOFF	1795 Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0186216	09-2004	Satoh et al.	524/502
	B	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 02/077116	10-2002		Satoh, K et al.	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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